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A site-controlled quantum dot system offering both high uniformity and spectral purity

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In this letter we report on the optical properties of site-controlled InGaAs quantum dots with GaAs barriers grown in pyramidal recesses by metalorganic vapor phase epitaxy. The inhomogeneous broadening of excitonic emission from an ensemble of quantum dots is found to be unusually narrow, with a standard deviation of 1.19 meV and the spectral purity of emission lines from individual dots is found to be very high (18–30 μeV), in contrast with other site-controlled dot systems. © 2009 American Institute of Physics. [DOI: 10.1063/1.3147213]

Semiconductor quantum dots (QDs) are currently of great scientific interest finding application in a vast array of fields spanning fundamental physical studies and cavity quantum electrodynamics, to reach the latest quantum information technologies.¹ The ability to control with nanometer precision, the location at which QDs are formed while maintaining the high optical quality which has, as far as now, always been a prerogative of self-assembled growth methods is an open challenge for researchers. Under nonresonant optical excitation, the exciton line of single self-assembled QDs grown under the Stransky–Krastanov growth mode with molecular beam epitaxy (MBE) is usually broadened by the coupling of the QD excitons to phonons and to fluctuating charges in its environment. However, a small emission linewidth close to the limit imposed by the uncertainty principle can be observed sometimes at low temperature, provided high resolution setups, and appropriate pumping conditions (e.g., pumping with a small excess energy) are used.^{2,3} For site-controlled systems the spectral purity of the single dot excitonic emission is typically poorer than in self-organized systems and producing $<50 \mu\text{eV}$ linewidths^{4,5} in a reproducible way is challenging, though some progress has been made recently.⁶ This is attributed to unintentional impurity incorporation that is associated with the pregrowth lithographic process needed to achieve the site-controlled nucleation. Moreover, metalorganic vapor phase epitaxy (MOVPE), which relies on growth precursors and has working pressures far from the ultrahigh-vacuum conditions used for MBE, has failed, so far, to produce very narrow excitonic linewidths even when self-organized growth is employed.⁷

In this letter we introduce a site-controlled QD system grown by MOVPE in large (7.5 μm) inverted tetrahedral recesses on (111)*B* GaAs substrates. We present an evolution to the InGaAs pyramidal QD system, which raised considerable interest in the community particularly because of its high uniformity.⁸ We show that it is possible to replace the $\text{Al}_y\text{Ga}_{1-y}\text{As}$ barrier material with GaAs and that the growth process can then be performed at a relatively high temperature. This delivers improved epitaxial quality and critically preserves the delicate equilibrium between growth rate anisotropy and capillarity processes that leads to a self limiting profile and finally, dot formation.⁴ We present the results of

optical studies of this system, in particular we show: the ability to tune the emission wavelength, high uniformity of the emission energy of the neutral exciton, and a neutral exciton emission of unprecedented spectral purity for single QDs grown by MOVPE.

The samples used in this study were grown by MOVPE on a (111)*B* GaAs substrate patterned with a matrix of tetrahedral recesses with a 7.5 μm pitch. These recesses, whose inner surfaces are oriented along the (111)*A* crystallographic directions, are obtained by standard lithography and wet chemical etching.⁴ Growth conditions, temperature (730 °C thermocouple), V/III ratio (in the range of 600–800), and the material structure surrounding the QD layer were nominally the same for all samples. Following a buffer layer of GaAs, $\text{Al}_y\text{Ga}_{1-y}\text{As}$ was grown with a gradually varying composition from $\text{Al}_{0.30}\text{Ga}_{0.70}\text{As}$ to $\text{Al}_{0.75}\text{Ga}_{0.25}\text{As}$. Next a layer of $\text{Al}_{0.75}\text{Ga}_{0.25}\text{As}$ was grown to act as an etch stop to aid the post-growth process of substrate removal (backetching)⁴ which is employed to allow optical studies of the pyramids in the apex-up geometry. Finally the QD and barrier layers are grown sandwiched between $\text{Al}_{0.55}\text{Ga}_{0.45}\text{As}$ cladding to provide carrier confinement. The width of the GaAs barrier beneath (above) the dot layer was 100 (70) nm. Four samples (A–D) were grown for this study each with a different composition of $\text{In}_x\text{Ga}_{1-x}\text{As}$ in their respective 0.5 nm thick QD layers; for samples A, B, C, and D the compositions respectively were, $x=0.15, 0.25, 0.35,$ and 0.45 . The sample structure following the etch-stop layer is illustrated in Fig. 1, the vertical quantum wire⁴ that forms through the center of the structure is illustrated. While comprising a similar material system, this design is physically different to the one reported recently in Ref. 9 In the work by Gallo *et al.* the dimensions of the pyramidal template are >20 times smaller than in ours and, critically, on the order of the adatom diffusion length, thus the growth dynamics in their system and results they find are quite different to those presented here.

We characterized our structures optically by measuring microphotoluminescence (μPL) with nonresonant excitation at 658 nm. Samples were studied in two different geometries: “as-grown,” with the apex of the pyramids facing down, and, following substrate removal with a selective etch, “apex-up.” The latter increases the proportion of the emitted light which is collected by our microscope objective by three orders of magnitude; the process also induces a redshift in the QD emission of $\sim 20 \text{ nm}$.⁴ The system resolution was $\sim 10 \mu\text{eV}$

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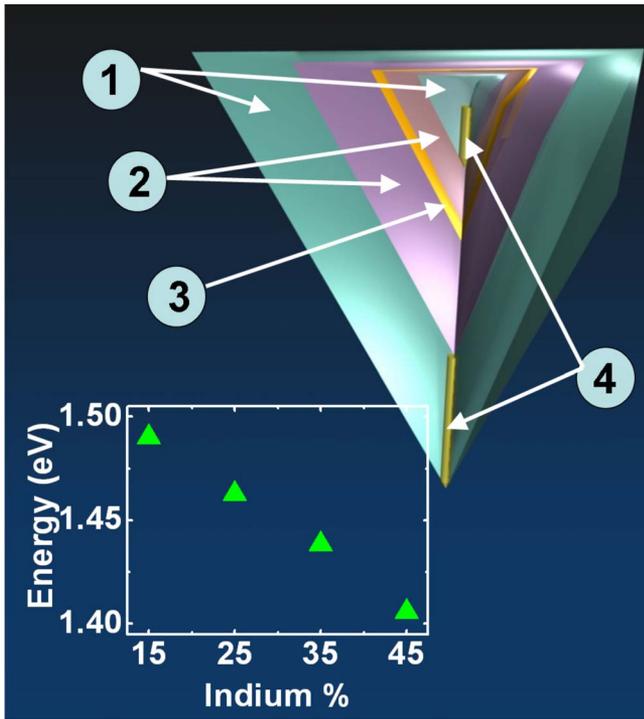


FIG. 1. (Color online) An illustration of the sample layer structure following the etch-stop layer used to facilitate substrate removal. Label 1—Al_{0.55}Ga_{0.45}As layer, 2—GaAs barriers, 3—In_xGa_{1-x}As dot layer, and 4—vertical quantum wire. Inset: emission energy tuning as a function of indium percentage in the QD composition.

(2 pixels) at 800 nm and the sample were studied at <10 K in a helium closed-cycle cryostat.

The average emission wavelength of the neutral exciton from a single dot for the four samples in the as-grown geometry is shown in Fig. 1 (inset). As the emission wavelength for sample A coincides with emission from GaAs the value shown in the figure was extrapolated from a measurement in the apex-up geometry. As the concentration of indium in the In_xGa_{1-x}As alloy across the four samples was increased a clear shift in the emission wavelength from ~830 nm (In_{0.15}Ga_{0.85}As) to 882 nm (In_{0.45}Ga_{0.85}As) was observed. This is attributed to an increase in the depth of the potential well in which the excitons' wave function is confined. The wavelength shift of the emission is much smaller than would be expected naively in comparing the bandgaps of the In_xGa_{1-x}As compositions of the four samples. This

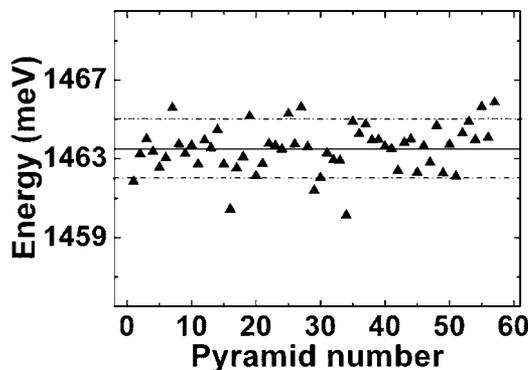


FIG. 2. The emission energy of the neutral exciton emission measured for a large number of pyramids from sample B. The solid line marks the average value and the two dashed lines mark the FWHM of the Gaussian fit.

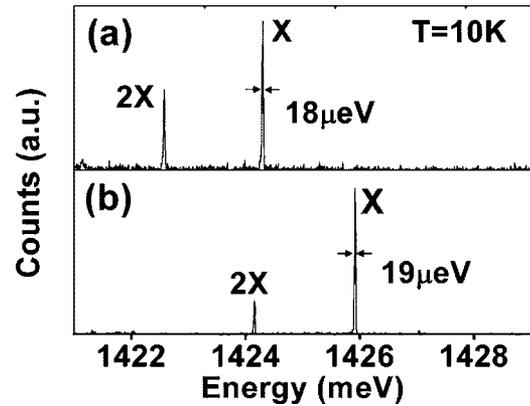


FIG. 3. (μ PL) spectra taken from two different individual QDs. Emission from the neutral exciton (X) and biexciton (2X) states is labeled. The width of the neutral exciton peaks were extracted by fitting a Lorentzian peak. Integration times and excitation intensities are different for the two spectra.

implies that a small fraction of the excitons' wave function resides in the dot; this will be the focus of theoretical studies of this system in the future.

The uniformity in the emission wavelength from sample B in the as-grown geometry is illustrated in Fig. 2 which plots the neutral exciton energy for a *large* number of individual pyramids. The average emission energy of the neutral exciton line, which was identified by mean of power dependencies and exchange splitting measurements was found to be 1463.5 meV with a standard deviation of only 1.19 meV, the full width half maximum (FWHM) of the corresponding interpolated Gaussian fit is 2.8 meV which is, slightly smaller than the results obtained in Refs. 6 and 8.

Prior to substrate removal, in the as-grown geometry, the excitonic emission of a single QD is found to be relatively broad, with linewidths up to 90 μ eV found on all the samples. In this geometry both the input- and output-coupling efficiencies are poor and a relatively large laser power density (>30 nW/ μ m²) is required for nonresonant excitation. Following substrate removal the linewidth of the emission is found to be significantly reduced. Figure 3 shows two representative μ PL spectra of neutral exciton (X) and biexciton (2X) emission collected from individual QDs pumped with low excitation power densities. Linewidths of the neutral exciton lines were measured by fitting the spectra to Lorentzian line shapes and found to be 18.0 μ eV for (a) and 19.4 μ eV for (b). These results are comparable with those of best MBE growths of self-organized QDs and are significantly better than the previous best results reported for site-controlled QDs.^{4,5,8} As the pump power is increased, other lines associated to multiexcitonic complexes appear in the spectrum (not shown).

In conclusion we have introduced a site-controlled QD system, composed of an In_xGa_{1-x}As dot embedded in GaAs, demonstrating both high uniformity and spectral purity. Varying the composition of the In_xGa_{1-x}As QD allowed the emission energy of the neutral exciton to be tuned which could be of great value to experiment and promises development of a long-wavelength QD system for quantum information applications.

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- ¹C. H. Bennett and D. P. DiVincenzo, *Nature (London)* **404**, 247 (2000); J. M. Gerard, in *Topics in Applied Physics*, edited by P. Michler (Springer, New York, 2003), Vol. 90, p. 269; A. J. Shields, *Nat. Photonics* **1**, 215 (2007).
- ²C. Kammerer, C. Voisin, G. Cassabois, C. Delalande, Ph. Roussignol, F. Klopff, J. P. Reithmaier, A. Forchel, and J. M. Gerard, *Phys. Rev. B* **66**, 041306 (2002); M. Bayer and A. Forchel, *ibid.* **65**, 041308 (2002).
- ³K. Leosson, D. Birkedal, I. Magnusdottir, W. Langbein, and J. M. Hvam, *Physica E (Amsterdam)* **17**, 1 (2003); R. Hafenbrak, S. M. Ulrich, P. Michler, L. Wang, A. Rastelli, and O. G. Schmidt, *New J. Phys.* **9**, 315 (2007).
- ⁴E. Kapon, E. Pelucchi, S. Watanabe, A. Malko, M. H. Baier, K. Leifer, B. Dwir, F. Michelini, and M.-A. Dupertuis, *Physica E (Amsterdam)* **25**, 288 (2004), and references therein.
- ⁵P. Atkinson, M. B. Ward, S. P. Bremner, D. Anderson, T. Farrow, G. A. C. Jones, A. J. Shields, and D. A. Ritchie, *Jpn. J. Appl. Phys., Part 1* **45**, 2519 (2006); S. Kiravittaya, M. Benyoucef, R. Zapf-Gottwick, A. Rastelli, and O. G. Schmidt, *Appl. Phys. Lett.* **89**, 233102 (2006); T. Tran, A. Muller, C. K. Shih, P. S. Wong, G. Balakrishnan, N. Nuntawong, J. Tatebayashi, and D. L. Huffaker, *ibid.* **91**, 133104 (2007); D. Kim, W. Sheng, P. J. Poole, D. Dalacu, J. Lefebvre, J. Lapointe, M. E. Reimer, G. C. Aers, and R. L. Williams, *Phys. Rev. B* **79**, 045310 (2009).
- ⁶V. Troncale, K. F. Karlsson, E. Pelucchi, A. Rudra, B. Dwir, and E. Kapon, IEEE/LEOS Winter Topical Meeting Series on Nanophotonics, Innsbruck, Austria, 12–14 January 2009 (unpublished).
- ⁷T.-P. Hsieh, H.-S. Chang, W.-Y. Chen, W.-H. Chang, T. M. Hsu, N.-T. Yeh, W.-J. Ho, P.-C. Chiu, and J.-I. Chyi, *Nanotechnology* **17**, 512 (2006).
- ⁸M. H. Baier, S. Watanabe, E. Pelucchi, and E. Kapon, *Appl. Phys. Lett.* **84**, 1943 (2004); K. Leifer, E. Pelucchi, S. Watanabe, F. Michelini, B. Dwir, and E. Kapon, *ibid.* **91**, 081106 (2007).
- ⁹P. Gallo, M. Felici, B. Dwir, K. A. Atlasov, K. F. Karlsson, A. Rudra, A. Mohan, G. Biasiol, L. Sorba, and E. Kapon, *Appl. Phys. Lett.* **92**, 263101 (2008).